

# Tracker simulation

耿青林

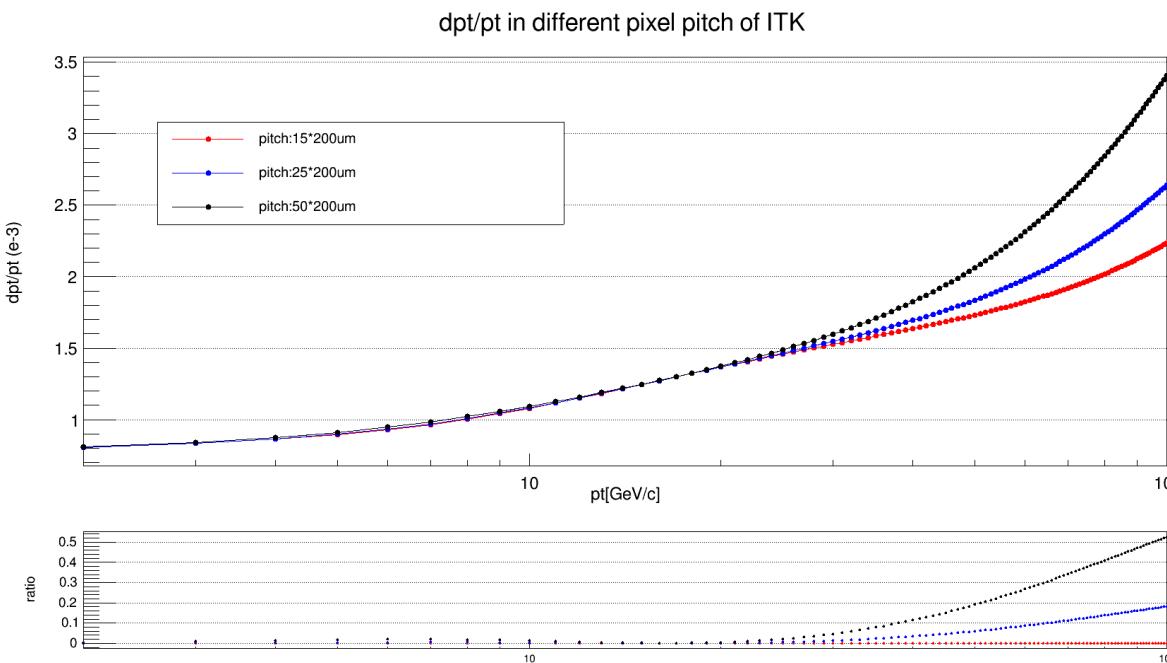
5.17

# Tracker Dimension (Barrel)

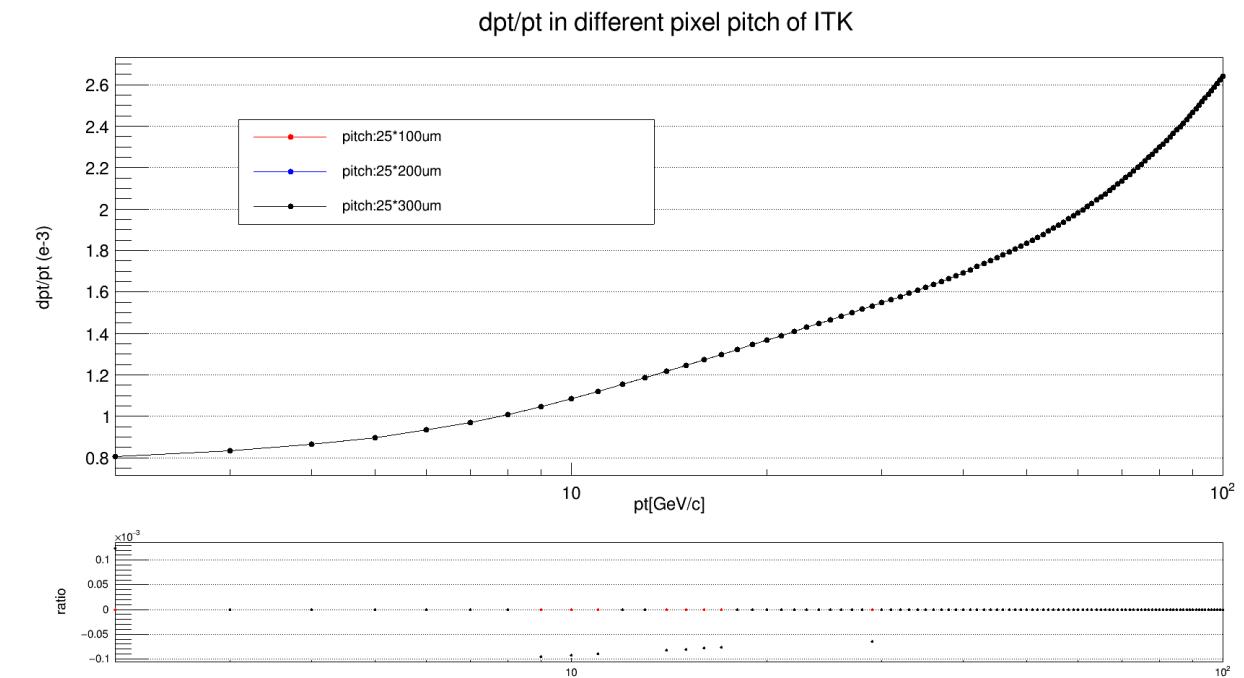
Components	Radius(mm)	Half Z (mm)	$\sigma_{R\phi}(\mu\text{m})$	$\sigma_z(\mu\text{m})$	Thickness( $X_0 \%$ )
Beam Pipe	10.35	-	-	-	0.172
VTX (3 double layers)	12.3/14.4/35.5/37.5/58.3/60.3		2.8/6/4/4/4/4	2.8/6/4/4/4/4	0.155
VTX-shell	65		-	-	0.139
SITs (3 layers)	150/250/500	740/1340/1890	<b>7.2</b>	<b>86.6</b>	0.650
DC inner wall	610	2980	-	-	0.110
DC cell (66 x18x18)	612-1800	-	100	2828	0.00127×66
DC outer wall	1802	-	-	-	1.349
SET	1811	2980	<b>7.2</b>	<b>86.6</b>	0.182

# pt resolution of ITK

固定z向pitch 为200um, Rphi向pitch分别取15、25、50um

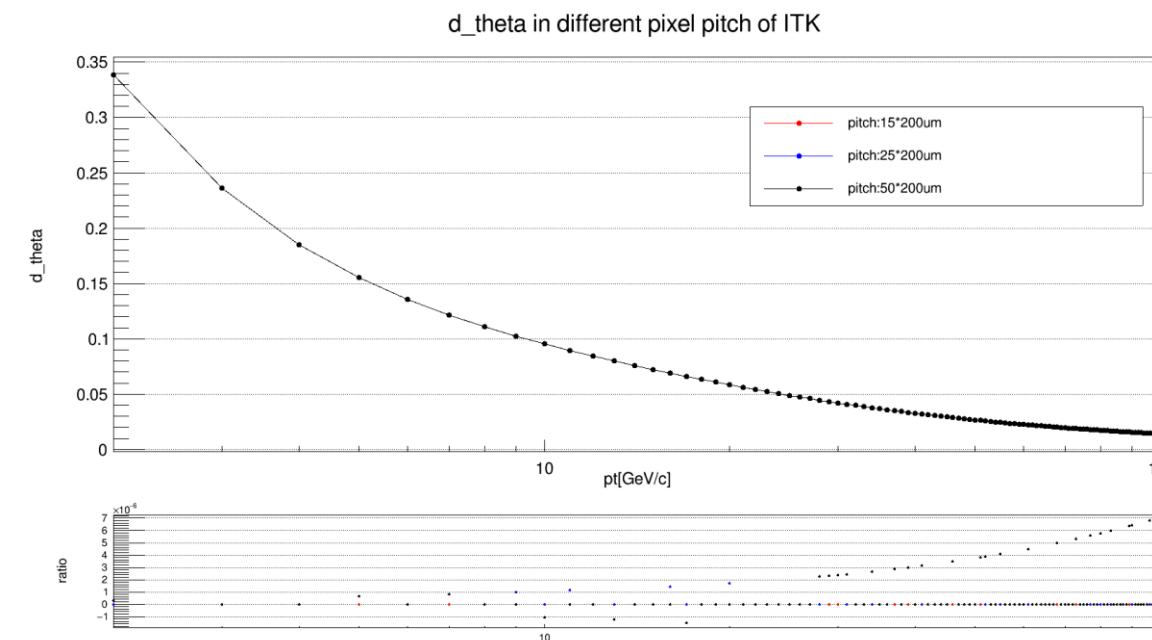


固定Rphi向pitch 为25um, z向pitch分别取100、200、300um

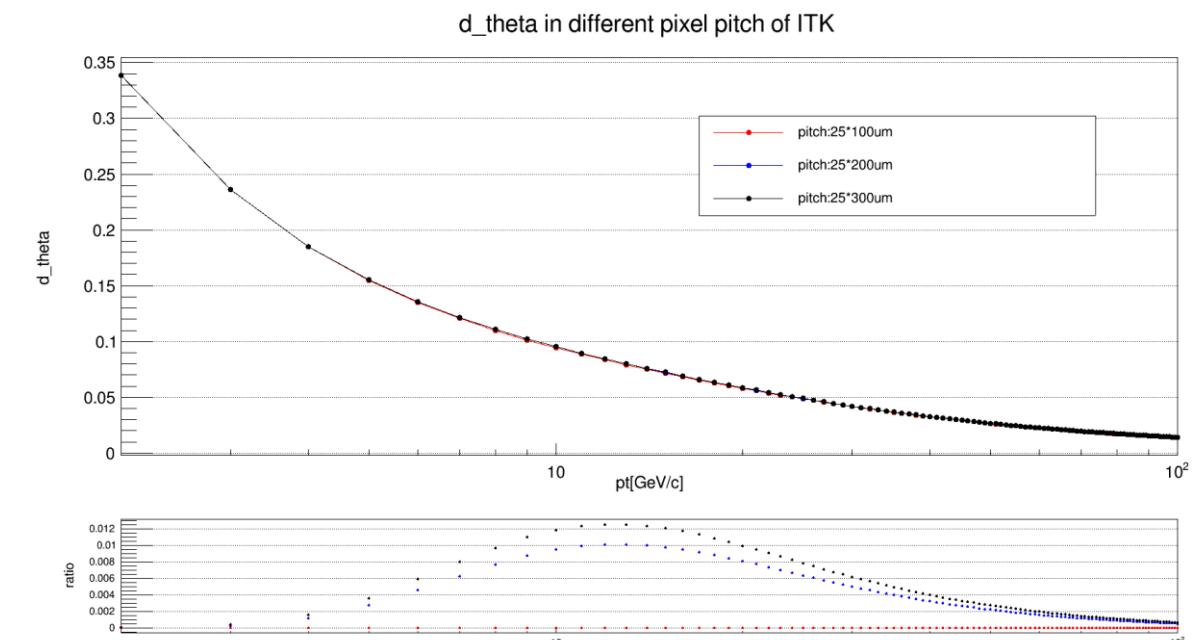


# theta resolution of ITK

固定z向pitch 为200um, Rphi向pitch分别取15、25、50um

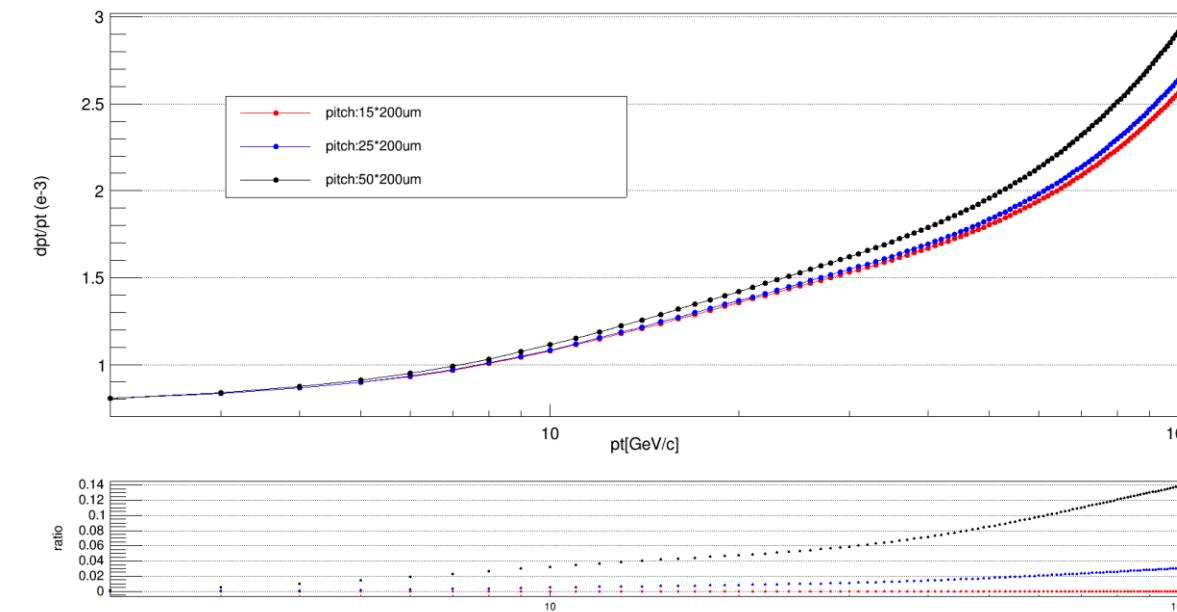


固定Rphi向pitch 为25um, z向pitch分别取100、200、300um



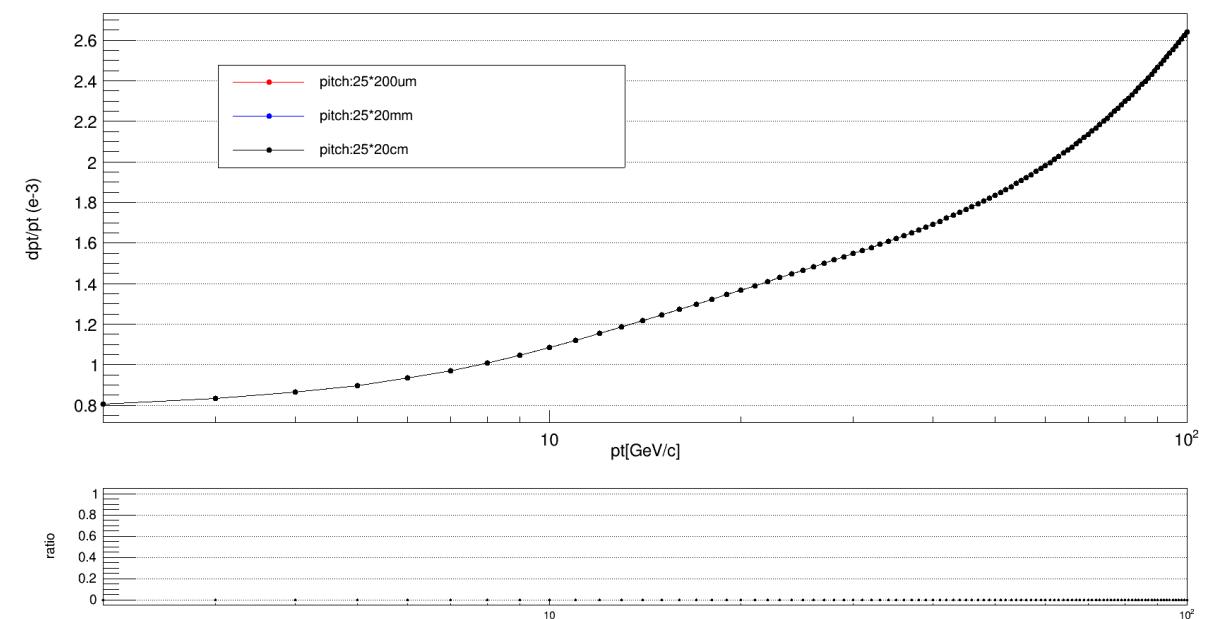
固定z向pitch 为200um, Rphi向pitch分别取15、25、50um

dpt/pt in different pixel pitch of OTK



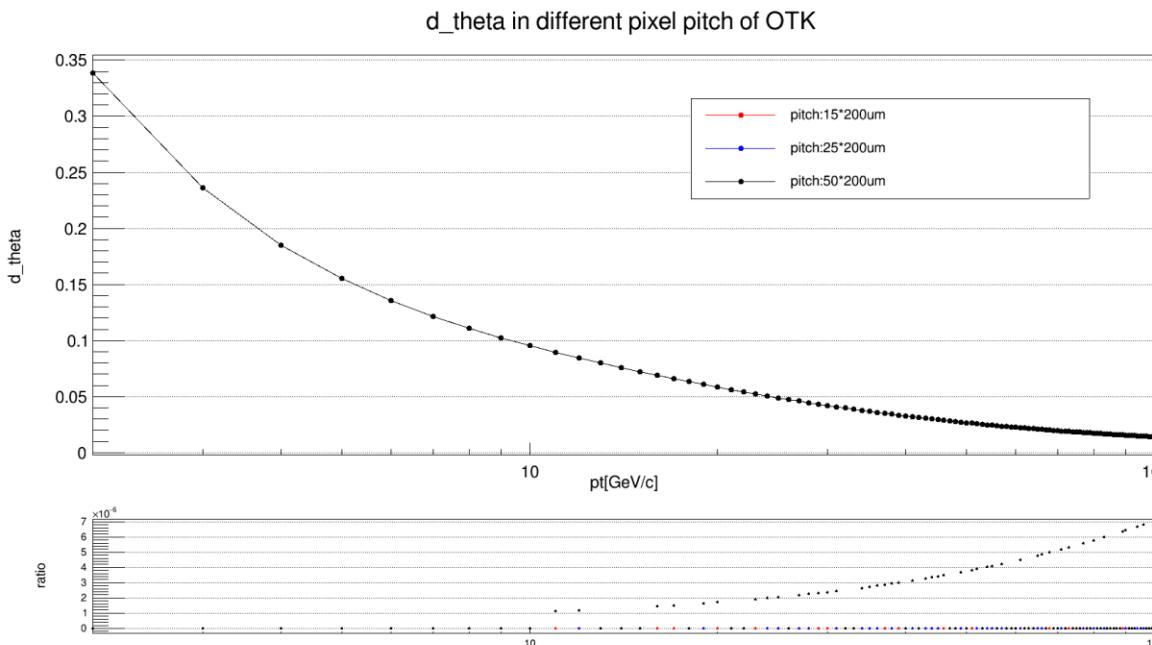
固定Rphi向pitch 为25um, z向pitch分别取200um、20mm、20cm

dpt/pt in different pixel pitch of OTK

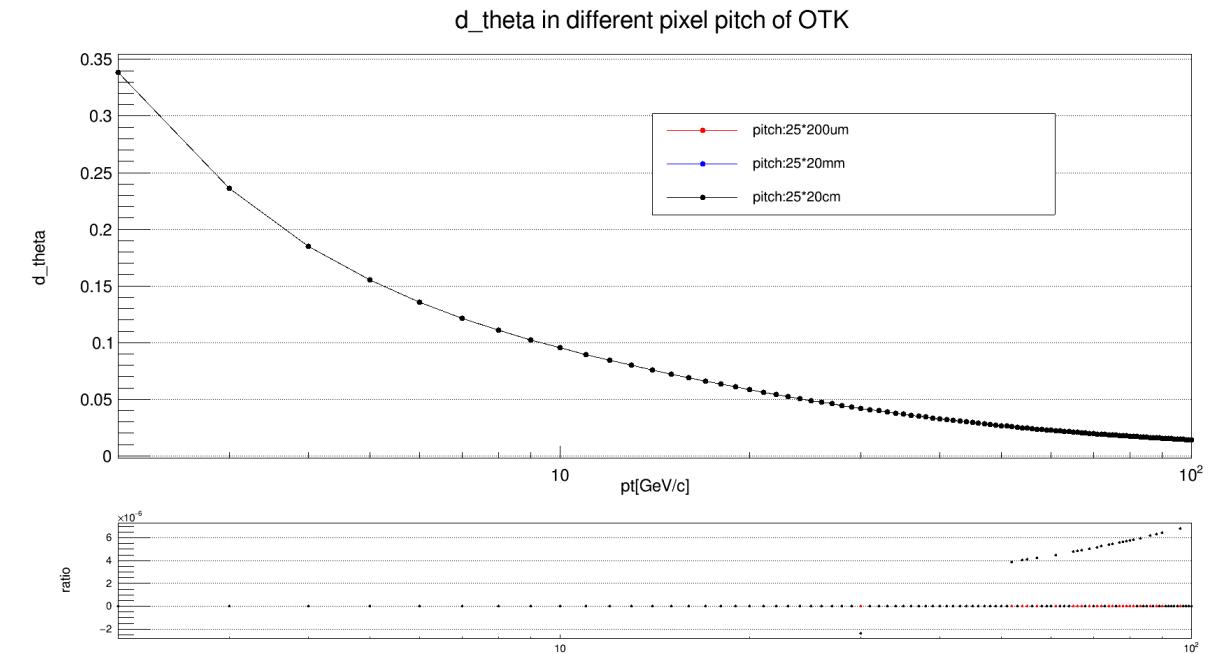


# theta resolution of OTK

固定z向pitch 为200um, Rphi向pitch分别取15、25、50um



固定Rphi向pitch 为25um, z向pitch分别取200um、20mm、20cm

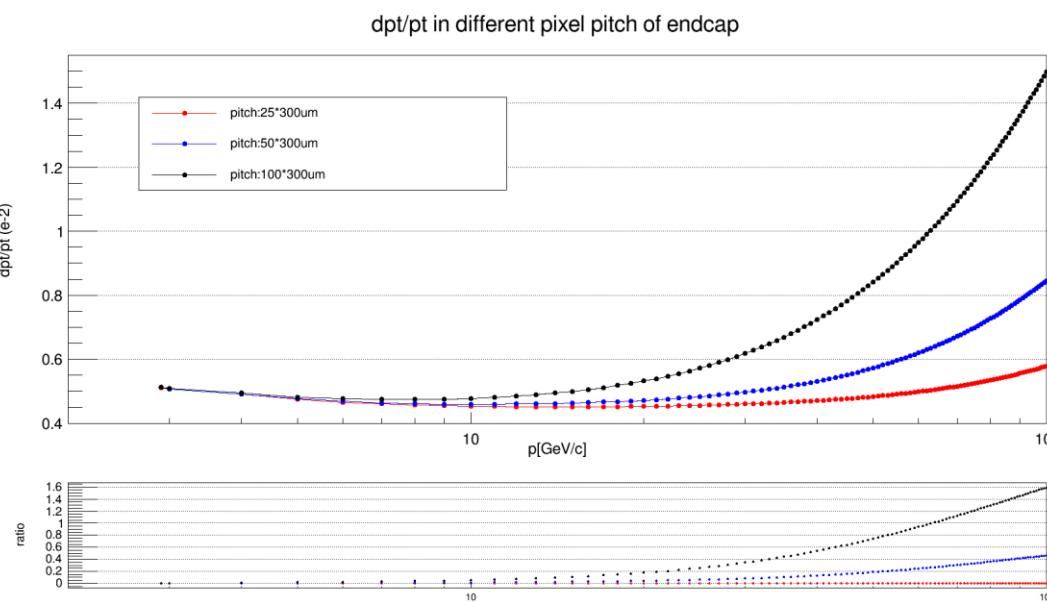


# Tracker Dimension (End Caps)

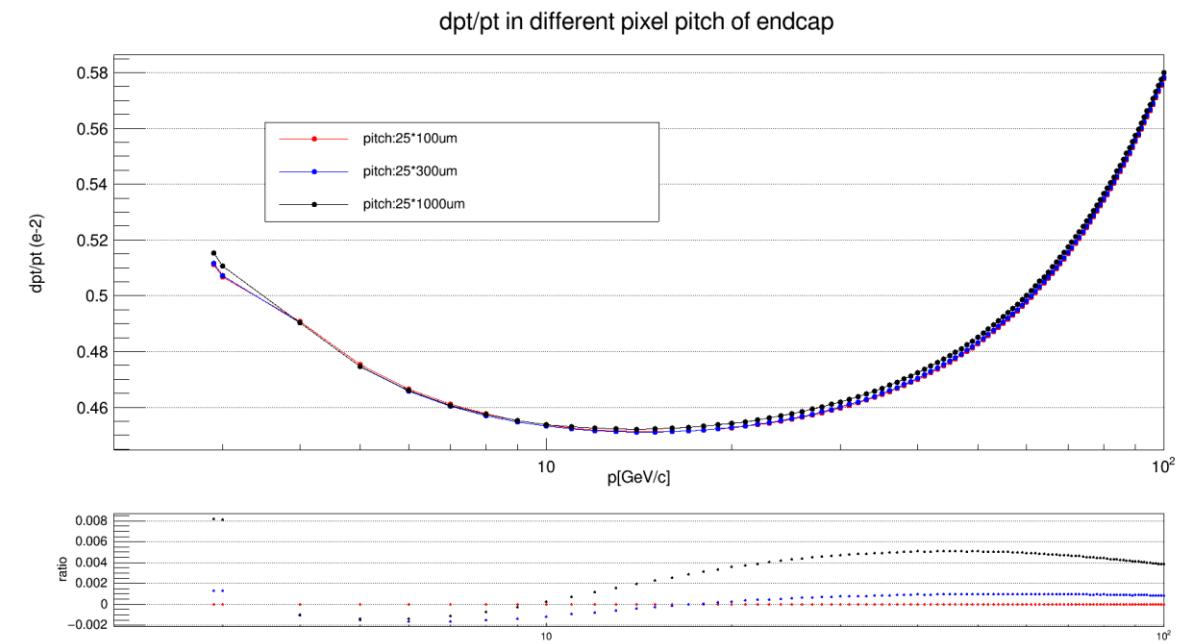
Components	Z (mm)	Rin(mm)	Rout(mm)	$\sigma_{R\phi}$ (mm)	$\sigma_R$ (mm)	Thickness( $X_0$ %)
VXD	200					0.65
SIT1	740	105	150	<b>7.2</b>	<b>86.6</b>	0.65
SIT2	1340	191	250	<b>7.2</b>	<b>86.6</b>	0.65
SIT3	1890	269	500	<b>7.2</b>	<b>86.6</b>	0.65
SET	2915	424	1811	<b>7.2</b>	<b>86.6</b>	0.65

# pt resolution of endcap

固定R向pitch 为300um, phi向pitch分别取  
25、50、100um

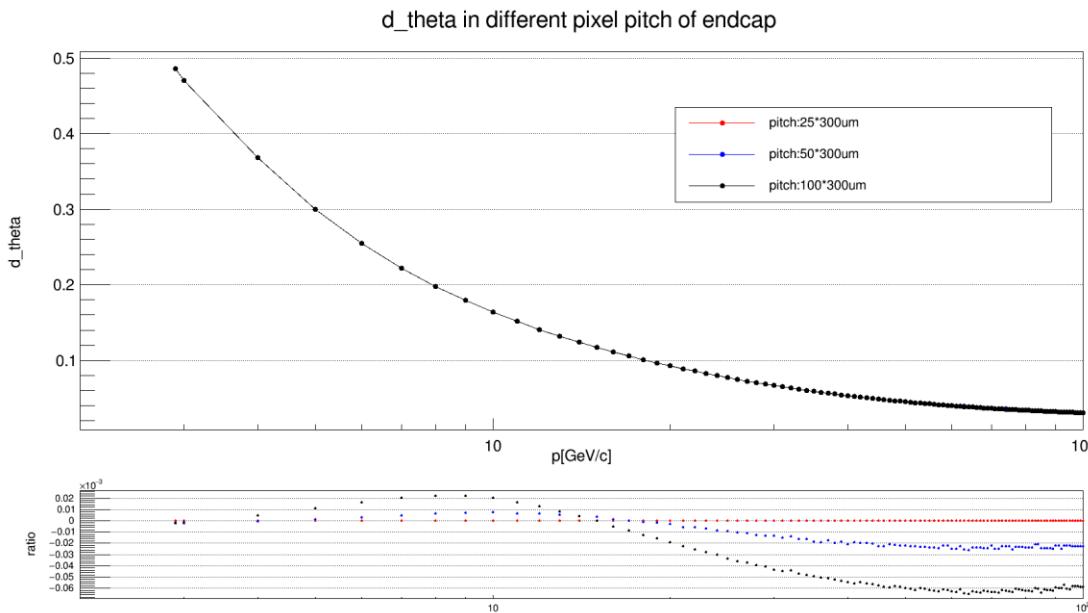


固定phi向pitch 为25um, R向pitch分别取  
100um、300um、1000um

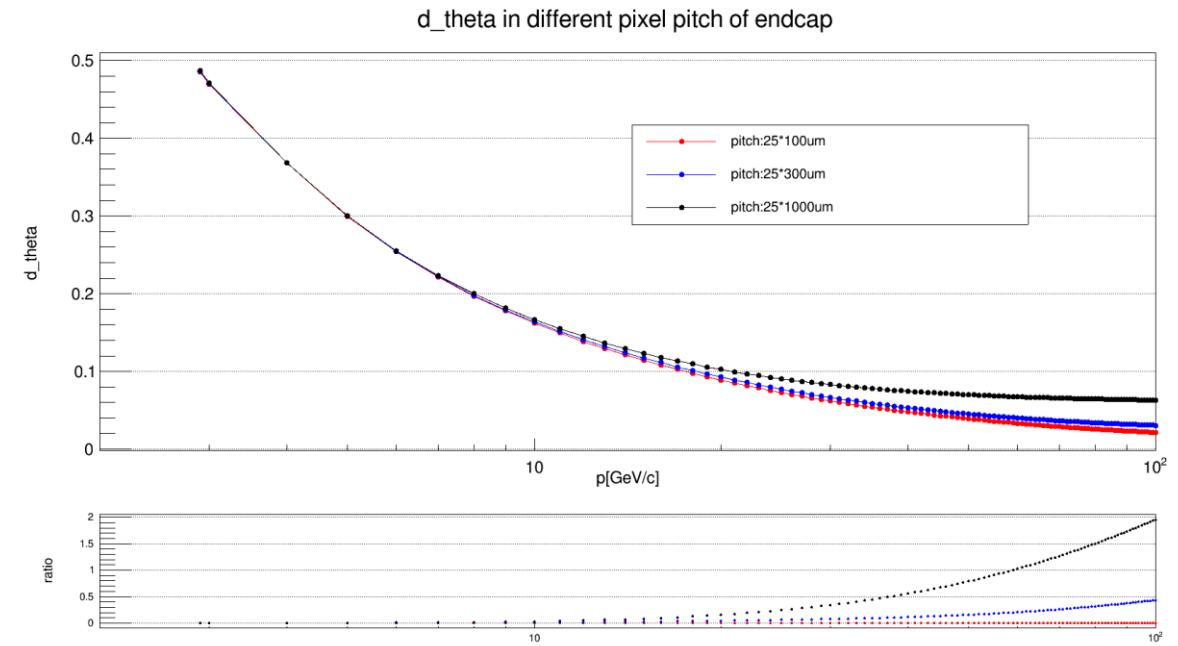


# theta resolution of endcap

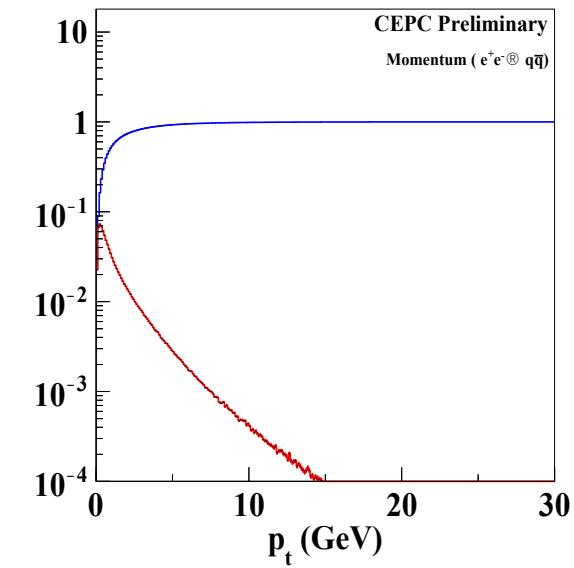
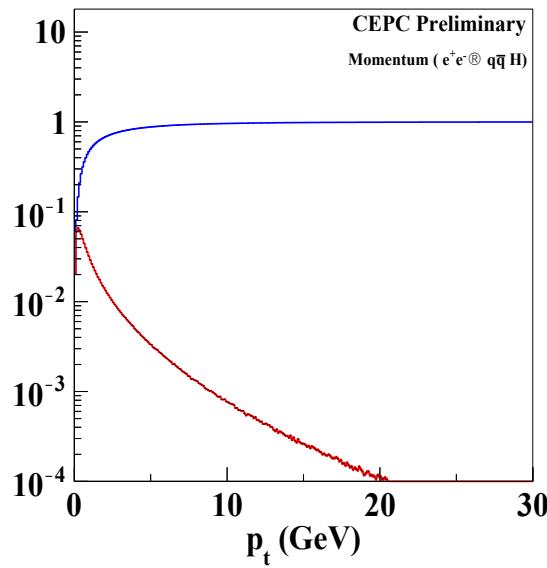
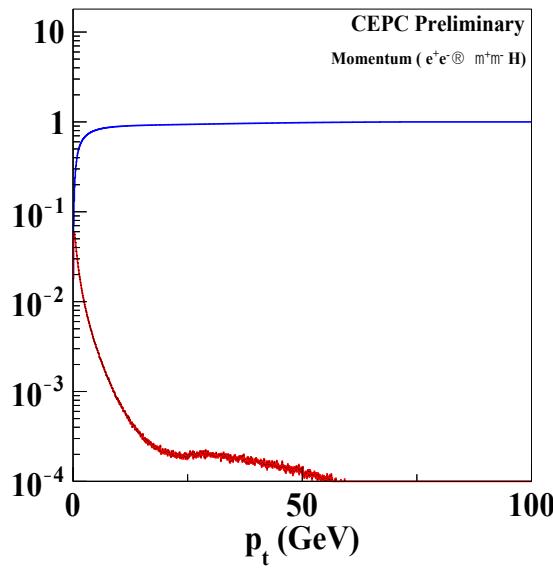
固定R向pitch 为300um, phi向pitch分别取  
25、50、100um



固定phi向pitch 为25um, z向pitch分别取  
100um、300um、1000um

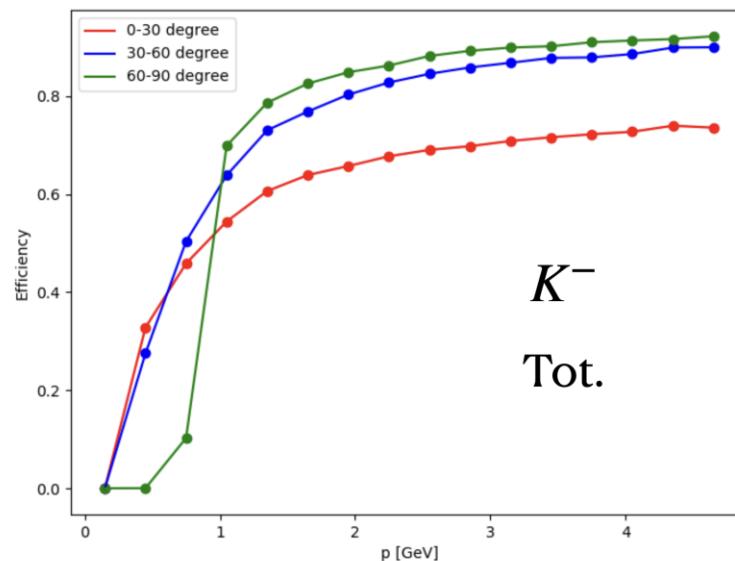


# Pt spectrum

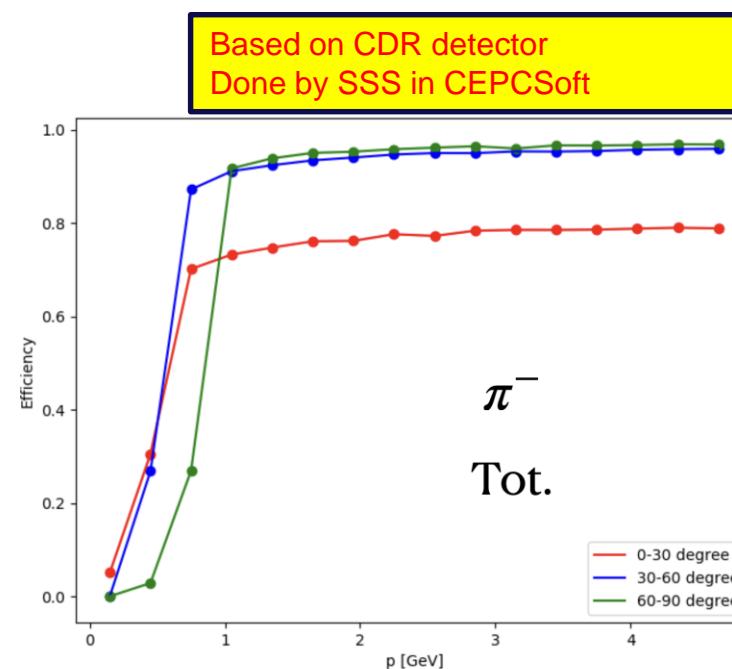


# Low momentum tracks

- ❖ Fractions of low pt tracks ( $\text{pt} < 1 \text{ GeV} \&\& \text{pt} > 0.1 \text{ GeV}$ )
  - $e^+e^- \rightarrow \mu\mu H$ : 42%
  - $e^+e^- \rightarrow q\bar{q}H$ : 46%
  - $e^+e^- \rightarrow Z \rightarrow b\bar{b}$ : 51%
- ❖ Lots of tracks of  $p < 1 \text{ GeV}$  hardly reaches ToF due to material and decay effect



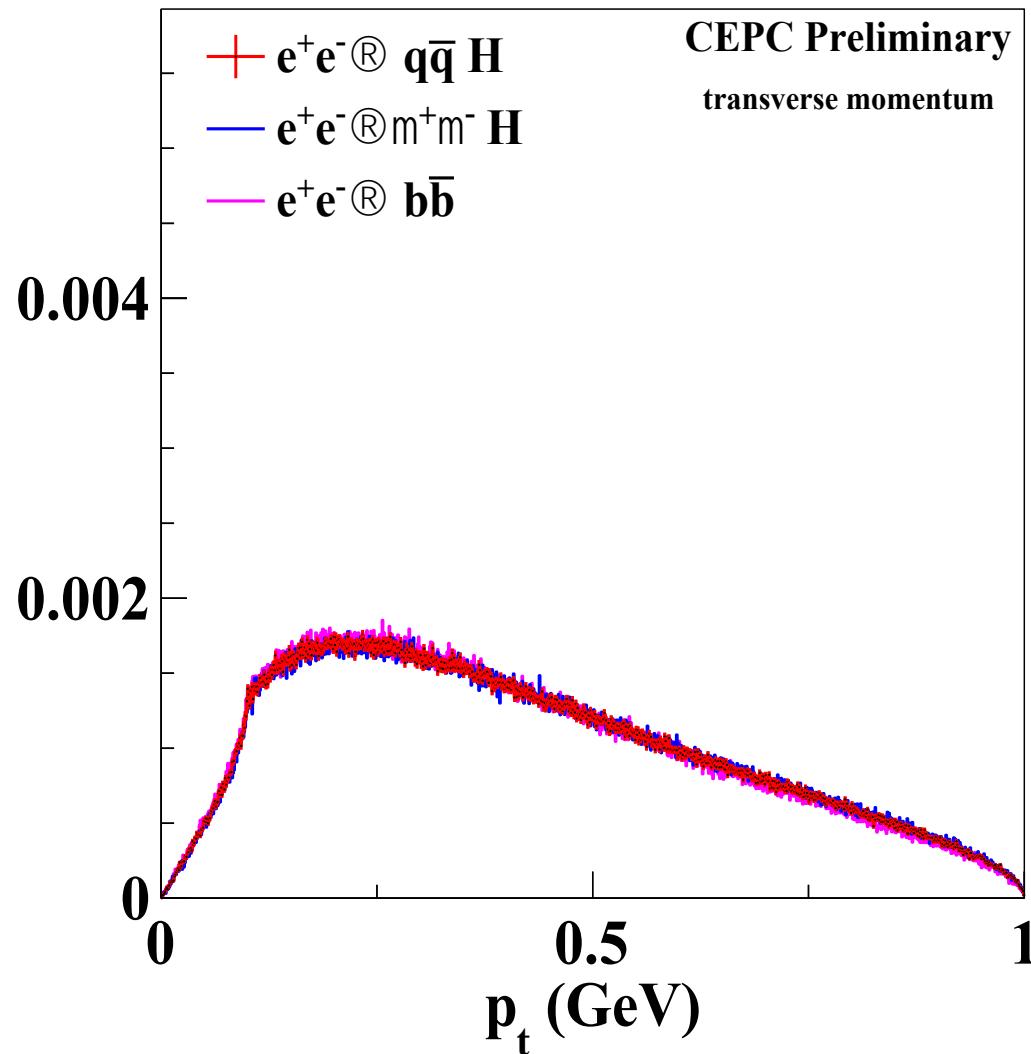
$K^-$   
Tot.



$\pi^-$   
Tot.

Curling when  $\text{pt} < 0.8 \text{ GeV}$  ( even larger due to materials )

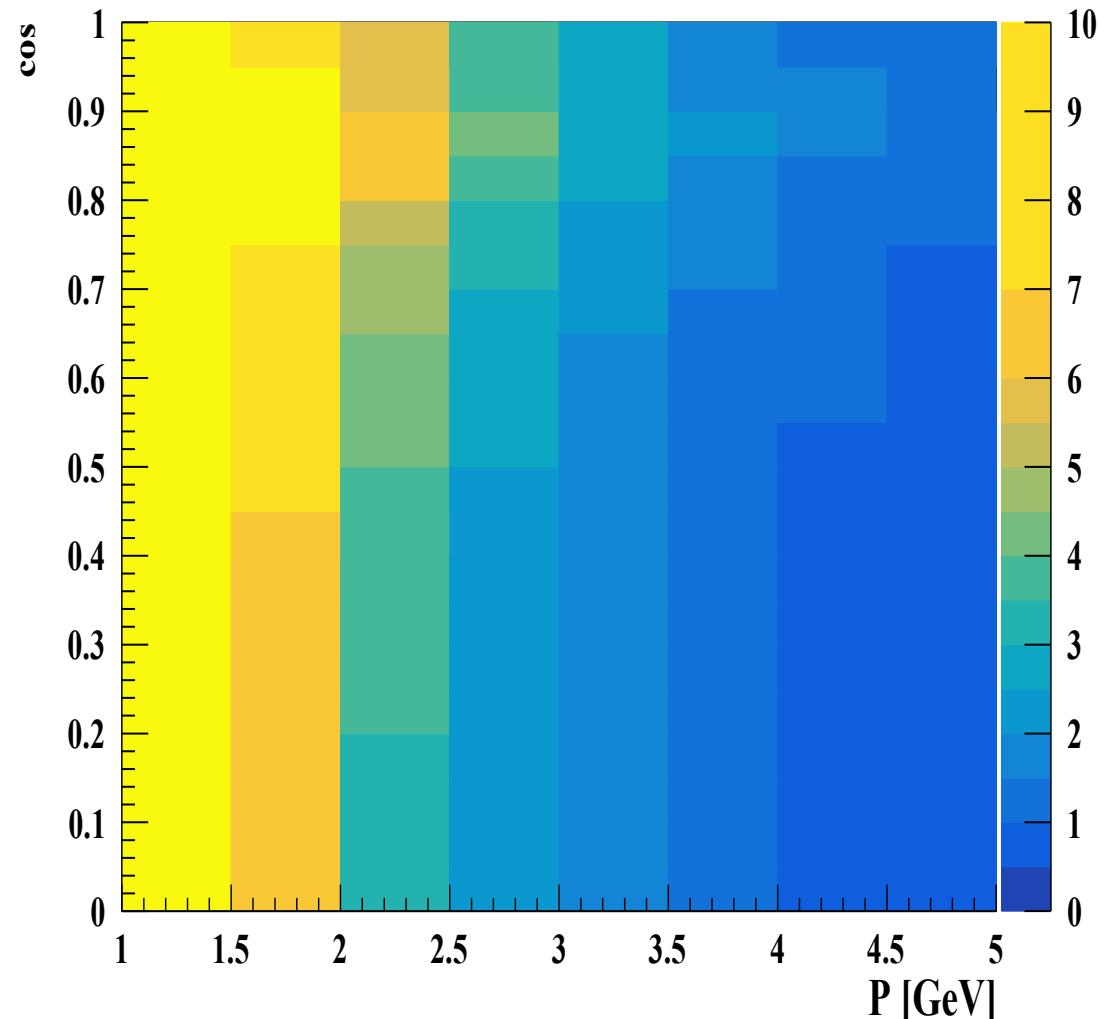
# pt distribution of tracks with $p < 1$ GeV



# PID performance with only ToF

50 ps time resolution, ToF only  
K/p Sep(tof)

Separation power



# Tracks can reach ToF

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Barrel or End cap	qqH(%) (3T)	mmH(%) (3T)	Z→qq (2T)(%)
Barrel	34.5	32.3	48.9
End cap	46.4	42.1	49.7

Barrel :  $|\cos \theta| < 0.85$

Barrel (3T):  $p_T > 0.81 \text{ GeV}$  &  $p_T < 3. \text{ GeV}$

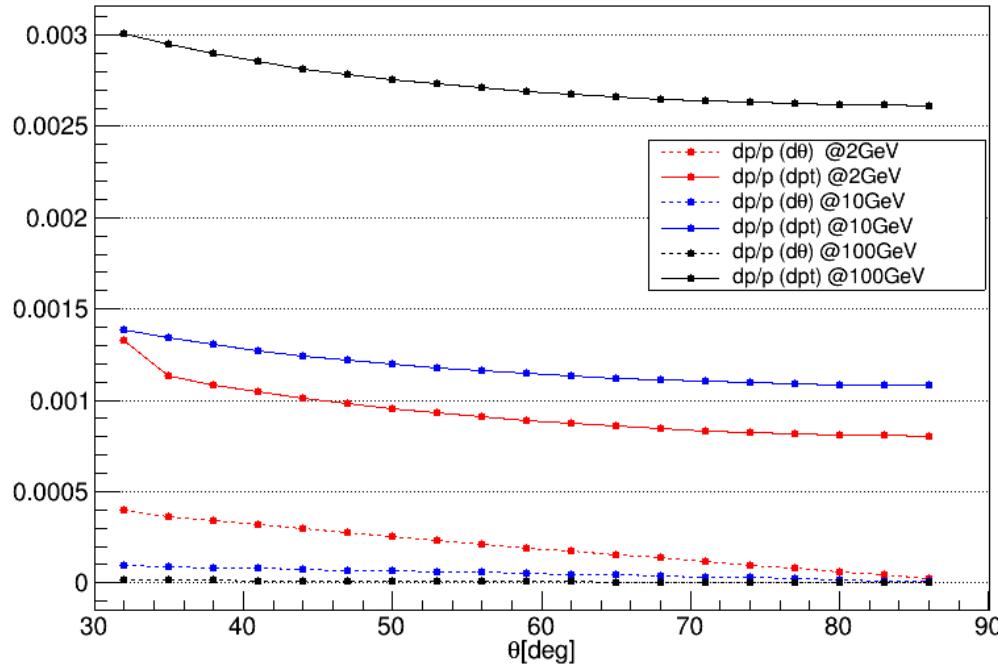
Endcap (3T):  $p_T > 0.20 \text{ GeV}$  &  $p_T < 3. \text{ GeV}$

Barrel (2T):  $p_T > 0.54 \text{ GeV}$  &  $p_T < 3. \text{ GeV}$

Endcap (2T):  $p_T > 0.20 \text{ GeV}$  &  $p_T < 3. \text{ GeV}$

# contribution of $d\theta$ & $dpt$ for $dp$

$dp(d\theta)$  and  $dp(dpt)$  vs  $\theta$

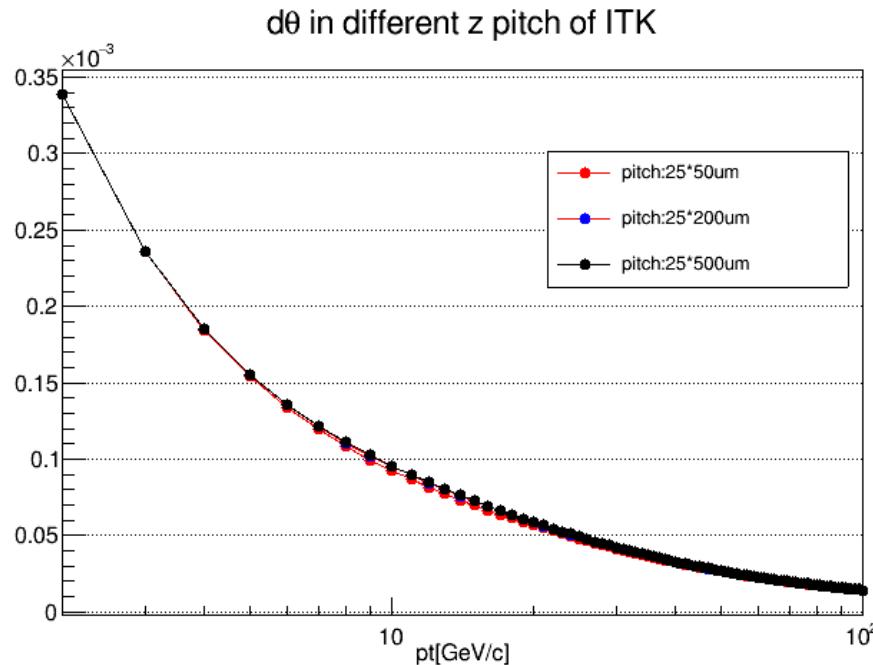


$$(dp/p)^2 = (dpt/pt)^2 + (d\theta/\tan\theta)^2$$

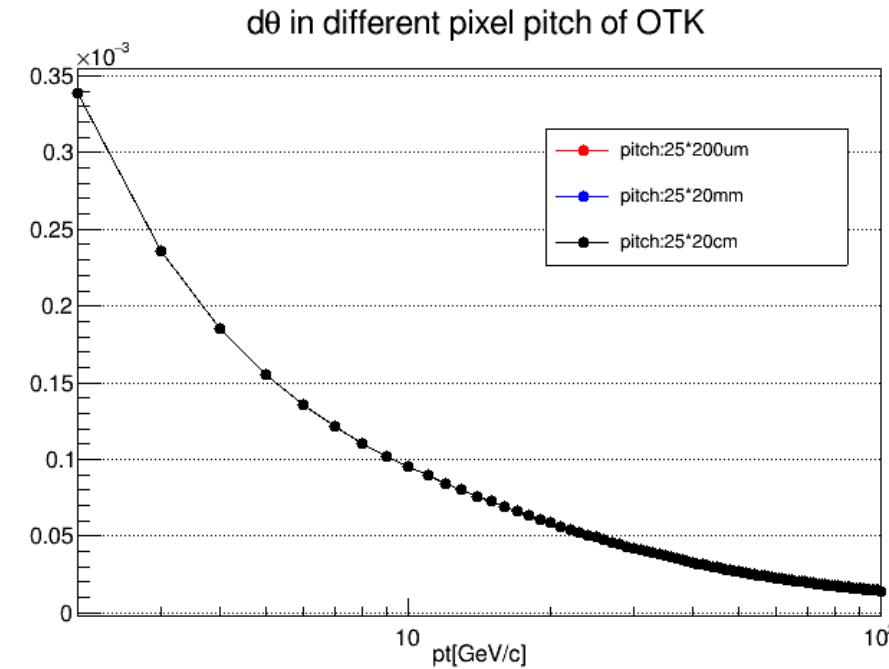
$\theta : 32^\circ \sim 86^\circ$ ,  $31.8^\circ$ 是OTK边缘的角度

pt=2GeV时,  $d\theta/\tan\theta$  的值约为  $dpt/pt$  的 $1/3$ ;  
pt=10、100GeV时, 两者差别在一个数量级以上

# $d\theta$ in different z pitch of ITK&OTK



固定OTK 的z向pitch为10cm



固定ITK 的z向pitch为200um

改变ITK 和OTK的z向分辨对  $\theta$ 的分辨  
影响都较小